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March 2015

FDD3510H

Dual N & P-Channel PowerTrench® MOSFET

N-Channel: 80V, 13.9A, $80m\Omega$ P-Channel: -80V, -9.4A, $190m\Omega$

Features

Q1: N-Channel

■ Max $r_{DS(on)}$ = 80m Ω at V_{GS} = 10V, I_D = 4.3A

■ Max $r_{DS(on)}$ = 88m Ω at V_{GS} = 6V, I_D = 4.1A

Q2: P-Channel

■ Max $r_{DS(on)}$ = 190m Ω at V_{GS} = -10V, I_D = -2.8A

■ Max $r_{DS(on)}$ = 224m Ω at V_{GS} = -4.5V, I_D = -2.6A

■ 100% UIL Tested

■ RoHS Compliant



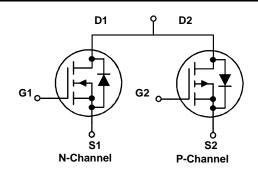
General Description

These dual N and P- Channel enha ncement mode Pow er MOSFETs ar e produ ced u sing Fa irchild Semiconductor 's advanced PowerT rench® process that has been especially tailored to minimize on -state r esistance and yet maint ain superior switching performance.

Applications

- Inverter
- H-Bridge





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

| Symbol | Parameter | | Q1 | Q2 | Units |
|-----------------------------------|--|--------------------------------|--------|------|-------|
| V_{DS} | Drain to Source Voltage | | 80 | -80 | V |
| V_{GS} | Gate to Source Voltage | | ±20 | ±20 | V |
| | Drain Current - Continuous | T _C = 25°C | 13.9 | -9.4 | |
| I_D | - Continuous | T _A = 25°C | 4.3 | -2.8 | Α |
| | - Pulsed | | 20 | -10 | |
| | Power Dissipation for Single Operation | T _C = 25°C (Note 1) | 35 | 32 | |
| P_{D} | | $T_A = 25^{\circ}C$ (Note 1a) | 3 | .1 | W |
| | | $T_A = 25^{\circ}C$ (Note 1b) | 1.3 | | |
| E _{AS} | Single Pulse Avalanche Energy | (Note 3) | 37 | 54 | mJ |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to | +150 | °C |

Thermal Characteristics

| $R_{	heta JC}$ | Thermal Resistance, Junction to Case, Single Operation for Q1 | (Note 1) | 3.5 | °C/W |
|-----------------|---|----------|-----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Single Operation for Q2 | (Note 1) | 3.9 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|-----------|-----------|------------|------------|
| FDD3510H | FDD3510H | TO-252-4L | 13" | 16mm | 2500 units |

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units |
|------------------------------------|---|--|----------|-----------|-----------|--------------|----------|
| Off Chara | cteristics | | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0V$ $I_D = -250 \mu A, V_{GS} = 0V$ | Q1 Q2 | 80 -80 | | | V |
| $\Delta BV_{DSS} \over \Delta T_J$ | Breakdown Voltage Temperature Coefficient | I_D = 250μA, referenced to 25°C I_D = -250μA, referenced to 25°C | Q1 Q2 | | 84 -67 | mV | /°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 64V, V_{GS} = 0V$ $V_{DS} = -64V, V_{GS} = 0V$ | Q1 Q2 | | | 1 -1 | μА |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = ±20V, V _{DS} = 0V | Q1 Q2 | | | ±100 ±100 | nA nA |

On Characteristics

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = -250 \mu A$ | Q1 Q2 | 2.0 -1.0 | 2.6 -1.6 | 4.0 -3.0 | V |
|--|---|--|----------|-------------|-------------------|-------------------|--------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = 250μA, referenced to 25°C I_D = -250μA, referenced to 25°C | Q1 Q2 | | -6.7 4.6 | mV/ | °C |
| | | $V_{GS} = 10V, I_D = 4.3A$ $V_{GS} = 6.0V, I_D = 4.1A$ $V_{GS} = 10V, I_D = 4.3A, T_J = 125^{\circ}C$ | Q1 | | 64 70 121 | 80 88 152 | mΩ |
| r _{DS(on)} | Static Drain to Source On Resistance | V_{GS} = -10V, I_D = -2.8A V_{GS} = -4.5V, I_D = -2.6A V_{GS} = -10V, I_D = -2.8A, T_J = 125°C | Q2 | | 153 184 259 | 190 224 322 | 1115.2 |
| 9 _{FS} | Forward Transconductance | $V_{DD} = 10V, I_D = 4.3A$ $V_{DD} = -5V, I_D = -2.8A$ | Q1 Q2 | | 15 6.8 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | Q1 V _{DS} = 40V, V _{GS} = 0V, f = 1MHZ | Q1 Q2 | 600 660 | 800 880 | pF |
|------------------|------------------------------|---|----------|------------|------------|----|
| C _{oss} | Output Capacitance | Q2 | Q1 Q2 | 56 50 | 75 70 | pF |
| C _{rss} | Reverse Transfer Capacitance | $V_{DS} = -40V, V_{GS} = 0V, f = 1MHZ$ | Q1 Q2 | 27 25 | 41 40 | pF |
| R _g | Gate Resistance | f = 1MHz | Q1 Q2 | 1.7 7.2 | | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | Q1 | Q1 Q2 | 7 6 | 13 11 | ns |
|---------------------|-------------------------------|--|----------|------------|----------|----|
| t _r | Rise Time | $V_{DD} = 40V, I_{D} = 4.3A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$ | Q1 Q2 | 2 | 10 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | Q2 V _{DD} = -40V, I _D = -2.8A, | Q1 Q2 | 16 25 | 29 40 | ns |
| t _f | Fall Time | $V_{GS} = -10V, R_{GEN} = 6\Omega$ | Q1 Q2 | 2 5 | 10 10 | ns |
| Q _{g(TOT)} | Total Gate Charge | Q1 | Q1 Q2 | 13 14 | 18 20 | nC |
| Q _{gs} | Gate to Source Charge | $V_{GS} = 10V, V_{DD} = 40V, I_D = 4.3A$ $Q2$ | Q1 Q2 | 2.3 1.9 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | $V_{GS} = -10V, V_{DD} = -40V, I_{D} = -2.8A$ | Q1 Q2 | 3.2 2.9 | | nC |

Units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Parameter

| Drain-S | Source Diode Characteristics | | | | | | |
|-----------------|---------------------------------------|---|----------------------|----------|-------------|-------------|----|
| V_{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0V, I_S = 2.6A$ $V_{GS} = 0V, I_S = -2.6A$ | (Note 2) (Note 2) | Q1 Q2 | 0.8 -0.8 | 1.2 -1.2 | V |
| t _{rr} | Reverse Recovery Time | Q1 I _F = 4.3A, di/dt = 100A/s | , , | Q1 Q2 | 29 30 | 46 48 | ns |
| Q _{rr} | Reverse Recovery Charge | Q2 I _F = -2.8A, di/dt = 100A/s | | Q1 Q2 | 28 30 | 45 48 | nC |

Test Conditions

Type

Min

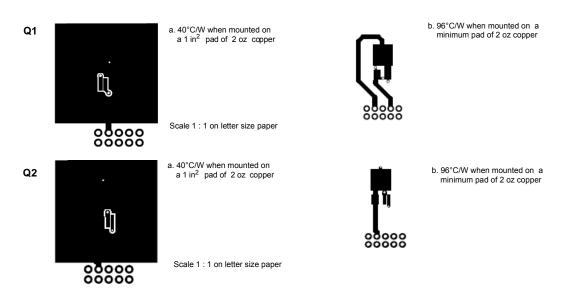
Тур

Max

Notes

Symbol

1. $R_{\theta JA}$ is determined with the device mounted on a 1in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. Starting $T_J = 25^{\circ}C$, N-ch: L = 3mH, $I_{AS} = 5A$, $V_{DD} = 80V$, $V_{GS} = 10V$; P-ch: L = 3mH, $I_{AS} = -6A$, $V_{DD} = -80V$, $V_{GS} = -10V$.

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

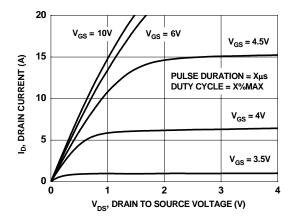


Figure 1. On Region Characteristics

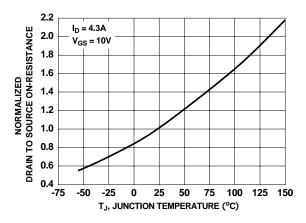


Figure 3. Normalized On Resistance vs Junction Temperature

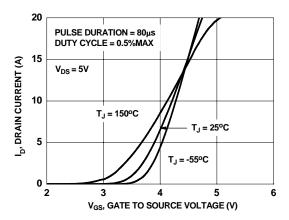


Figure 5. Transfer Characteristics

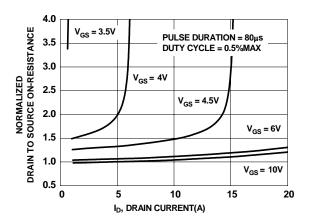


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

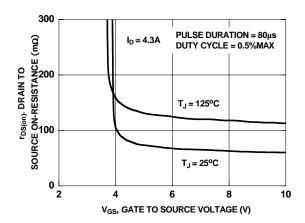


Figure 4. On-Resistance vs Gate to Source Voltage

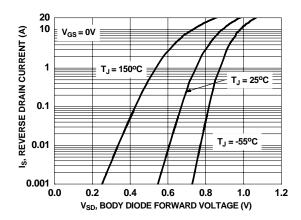


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

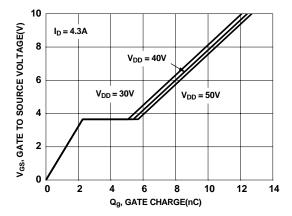


Figure 7. Gate Charge Characteristics

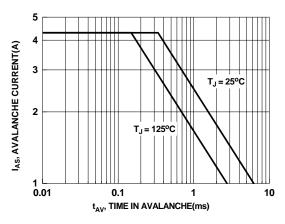


Figure 9. Unclamped Inductive Switching Capability

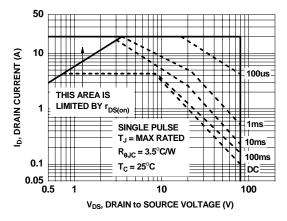


Figure 11. Forward Bias Safe Operating Area

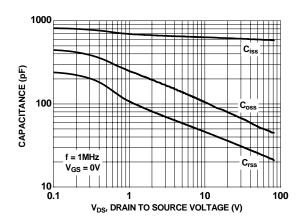


Figure 8. Capacitance vs Drain to Source Voltage

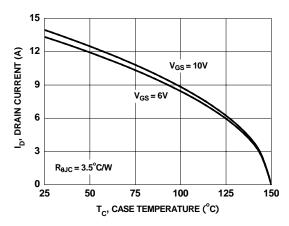


Figure 10. Maximum Continuous Drain Current vs Case Temperature

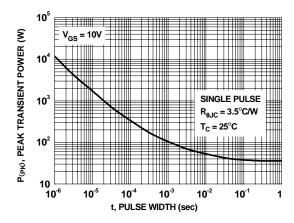


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

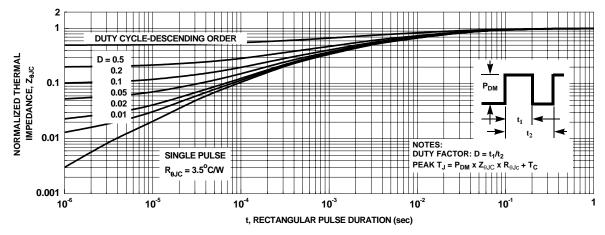


Figure 13. Transient Thermal Response Curve

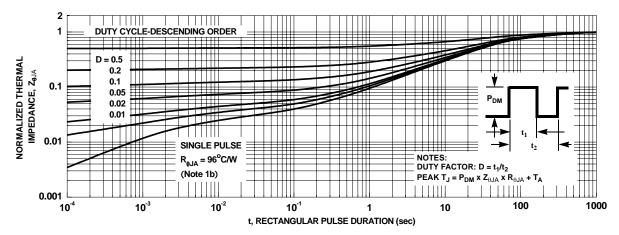


Figure 14. Transient Thermal Response Curve

Typical Characteristics (Q2 P-Channel) T_J = 25°C unless otherwise noted

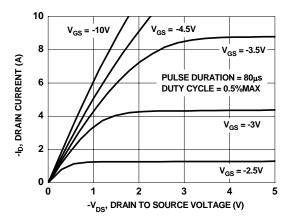


Figure 15. On- Region Characteristics

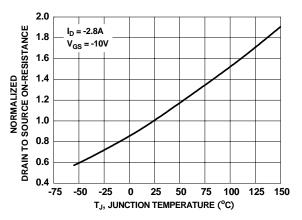


Figure 17. Normalized On-Resistance vs Junction Temperature

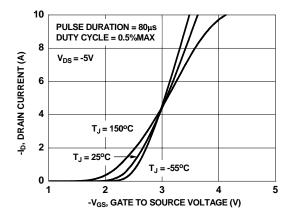


Figure 19. Transfer Characteristics

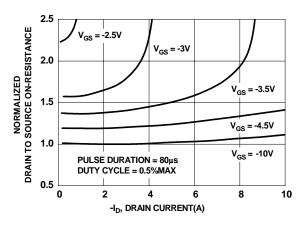


Figure 16. Normalized on-Resistance vs Drain Current and Gate Voltage

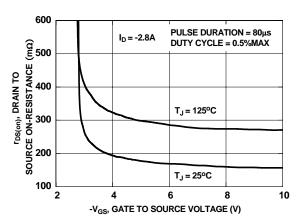


Figure 18. On-Resistance vs Gate to Source Voltage

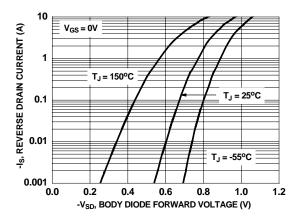


Figure 20. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q2 P-Channel)T_J = 25°C unless otherwise noted

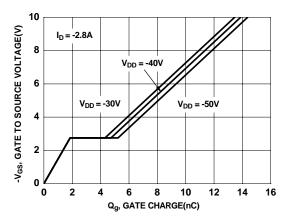


Figure 21. Gate Charge Characteristics

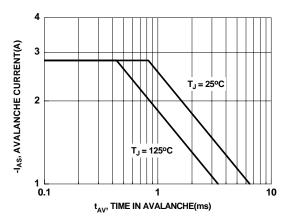


Figure 23. Unclamped Inductive Switching Capability

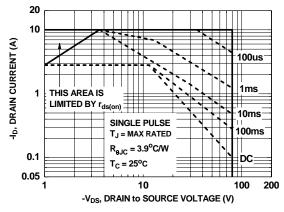


Figure 25. Forward Bias Safe Operating Area

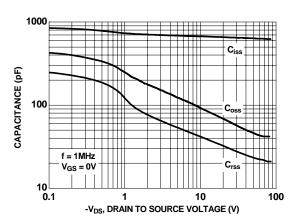


Figure 22. Capacitance vs Drain to Source Voltage

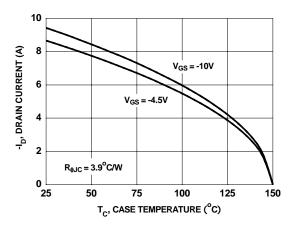


Figure 24. Maximum Continuous Drain Current vs Case Temperature

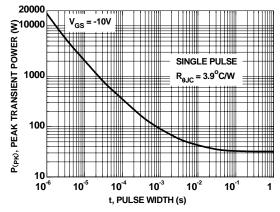


Figure 26. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 P-Channel)T_J = 25°C unless otherwise noted

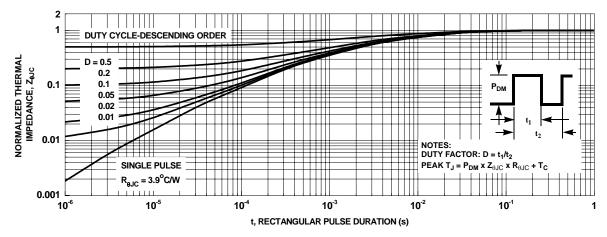


Figure 27. Transient Thermal Response Curve

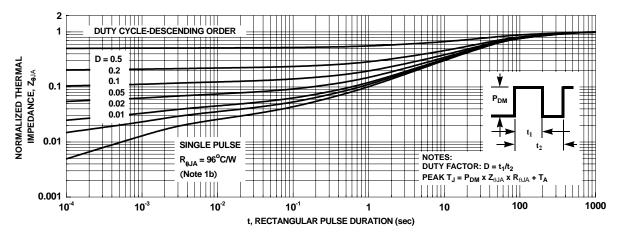
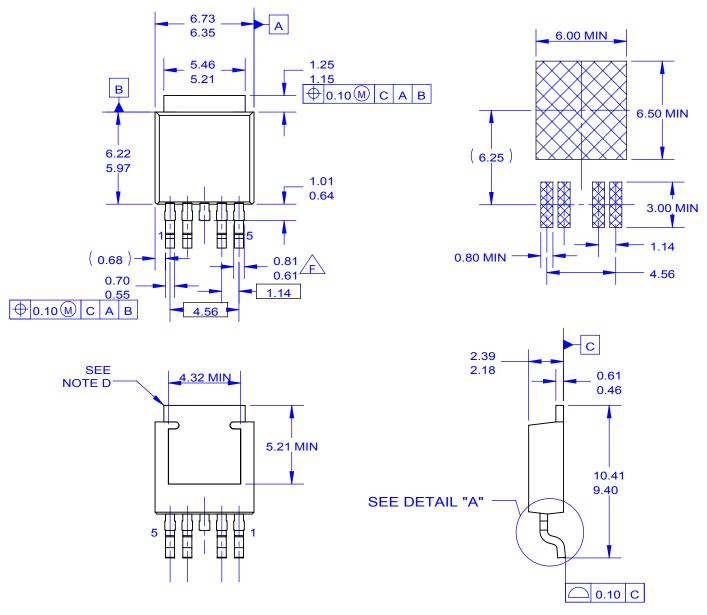
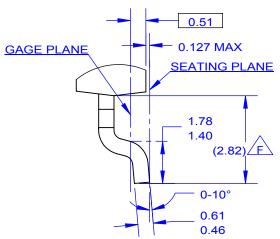


Figure 28. Transient Thermal Response Curve





DETAIL A SCALE 2:1

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